

June 2008

FDI025N06

N-Channel PowerTrench[®] MOSFET 60V, 265A, 2.5m Ω

Features

- $R_{DS(on)} = 1.9 m\Omega$ (Typ.) @ $V_{GS} = 10 V$, $I_D = 75 A$
- · Fast switching speed
- · Low gate charge
- High performance trench technology for extremely low R_{DS(on)}
- · High power and current handling capability
- · RoHS compliant



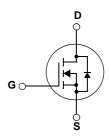
General Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance.

Application

• DC to DC convertors / Synchronous Rectification





MOSFET Maximum Ratings $T_C = 25^{\circ}C$ unless otherwise noted

Symbol		Parameter		Ratings	Units
V _{DSS}	Drain to Source Voltage			60	V
V _{GSS}	Gate to Source Voltage			±20	V
	Dunin Comment	-Continuous (T _C = 25°C)		265*	Α
I _D Drain Current		-Continuous (T _C = 100°C)		190*	Α
I _{DM}	Drain Current	- Pulsed	(Note 1)	1060	Α
E _{AS}	Single Pulsed Avalanche E	nergy	(Note 2)	2531	mJ
dv/dt	Peak Diode Recovery dv/d	t	(Note 3)	3.5	V/ns
Б	D	$(T_C = 25^{\circ}C)$		395	W
P_{D}	Power Dissipation	- Derate above 25°C		2.6	W/°C
T _J , T _{STG}	Operating and Storage Ter	nperature Range		-55 to +175	°C
TL	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds			300	°C

^{*}Calculated continuous current based on maximum allowable junction temperature. Package limitation current is 120A.

Thermal Characteristics

Symbol	Parameter	Ratings	Units
$R_{\theta JC}$	Thermal Resistance, Junction to Case	0.38	
$R_{\theta CS}$	Thermal Resistance, Case to Sink Typ.	0.5	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient 62.5		

Package Marking and Ordering Information $T_C = 25^{\circ}C$ unless otherwise noted

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDI025N06	FDI025N06	TO-262	-	-	50

Electrical Characteristics

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Off Charac	cteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V, T_C = 25^{\circ} C$	60	-	-	V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I _D = 250μA, Referenced to 25°C	-	0.04	-	V/°C
1	Zero Gate Voltage Drain Current	$V_{DS} = 60V, V_{GS} = 0V$	-	-	1	
IDSS	Zeio Gate voltage Drain Current	$V_{DS} = 60V, V_{GS} = 0V, T_{C} = 150^{\circ}C$	-	-	500	μА
I _{GSS}	Gate to Body Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$	-	-	±100	nA

On Characteristics

V _{GS(th)}	Gate Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 250\mu A$	2.5	3.5	4.5	V
R _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 10V, I_D = 75A$	-	1.9	2.5	mΩ
9 _{FS}	Forward Transconductance	$V_{DS} = 10V, I_D = 75A$ (No	ote 4) -	200	-	S

Dynamic Characteristics

C _{iss}	Input Capacitance	V 05V V 0V	-	11190	14885	pF
C _{oss}	Output Capacitance	$V_{DS} = 25V, V_{GS} = 0V$ f = 1MHz	-	1610	2140	pF
C _{rss}	Reverse Transfer Capacitance	1 - 1101112	-	750	1125	pF
Q _{g(tot)}	Total Gate Charge at 10V		-	174	226	nC
Q_{gs}	Gate to Source Gate Charge	$V_{DS} = 48V, I_{D} = 75A$	-	54	-	nC
Q_{gd}	Gate to Drain "Miller" Charge	V _{GS} = 10V (Note 4, 5)	=	50	-	nC

Switching Characteristics

t _{d(on)}	Turn-On Delay Time		-	134	278	ns
t _r	Turn-On Rise Time	$V_{DD} = 30V, I_{D} = 75A$	-	324	658	ns
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = 10V, R_{GEN} = 25\Omega$	-	348	706	ns
t _f	Turn-Off Fall Time	(Note		250	510	ns

Drain-Source Diode Characteristics

I_S	Maximum Continuous Drain to Source Diode Forward Current			-	-	265	Α
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current			-	-	1060	Α
V_{SD}	Drain to Source Diode Forward Voltage	$V_{GS} = 0V, I_{SD} = 75A$		-	-	1.3	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0V, I _{SD} = 75A		-	69	-	ns
Q _{rr}	Reverse Recovery Charge	$dI_F/dt = 100A/\mu s$	(Note 4)	-	152	-	nC

- Notes: 1: Repetitive Rating: Pulse width limited by maximum junction temperature 2: L = 0.9mH, $I_{AS} = 75A$, $V_{DD} = 50V$, $R_G = 25\Omega$, Starting $T_J = 25^{\circ}C$ 3: $I_{SD} \le 75A$, di/dt $\le 200A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$ 4: Pulse Test: Pulse width $\le 300\mu s$, Duty Cycle $\le 2\%$ 5: Essentially Independent of Operating Temperature Typical Characteristics

Typical Performance Characteristics

Figure 1. On-Region Characteristics

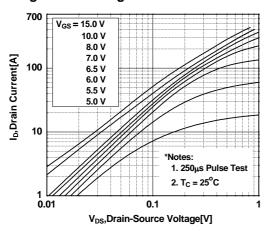


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

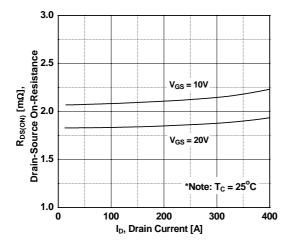


Figure 5. Capacitance Characteristics

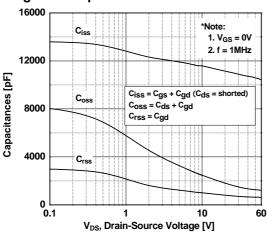


Figure 2. Transfer Characteristics

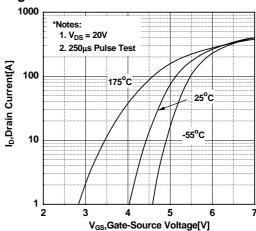


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

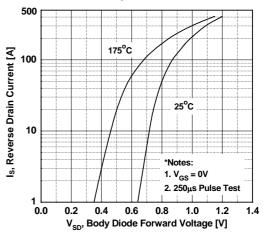
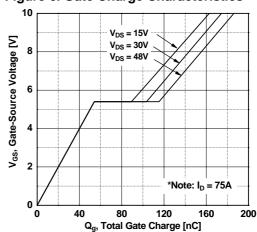


Figure 6. Gate Charge Characteristics



Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

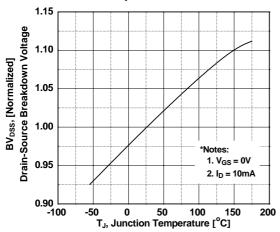


Figure 9. Maximum Safe Operating Area

1000 10µs ID, Drain Current [A] 100με 100 10ms · Operation in This Area 10 is Limited by R DS(on) *Notes: 1. T_C = 25°C 2. T_J = 175°C 3. Single Pulse 0.1 10 100 V_{DS}, Drain-Source Voltage [V]

Figure 8. On-Resistance Variation vs. Temperature

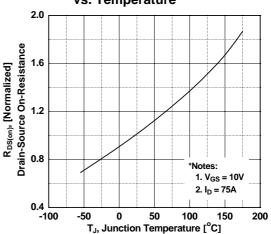


Figure 10. Maximum Drain Current vs. Case Temperature

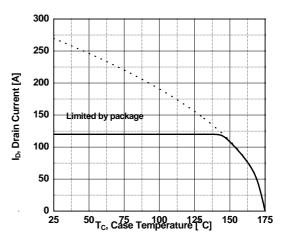
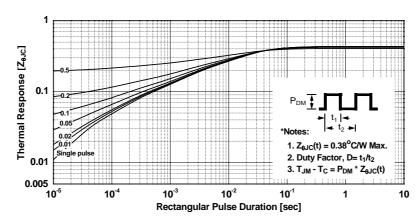
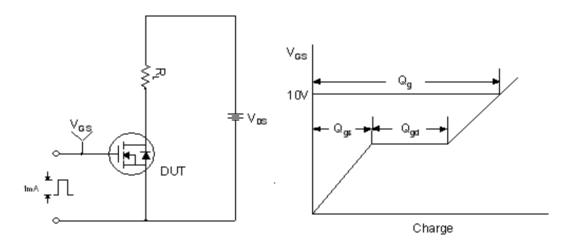


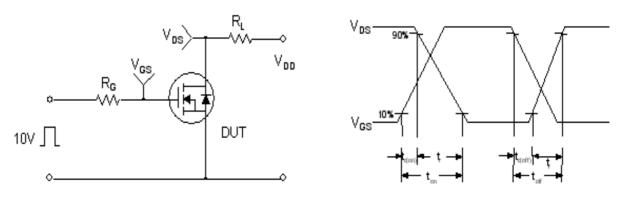
Figure 11. Transient Thermal Response Curve



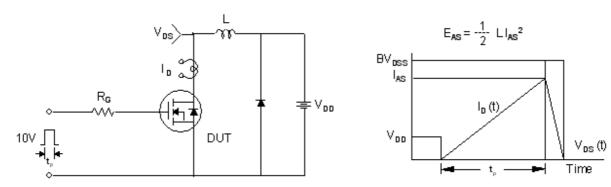
Gate Charge Test Circuit & Waveform



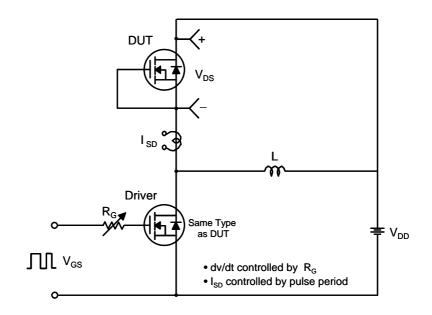
Resistive Switching Test Circuit & Waveforms

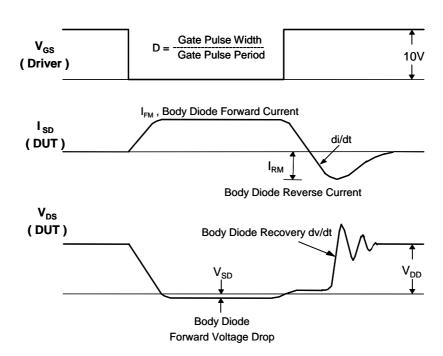


Unclamped Inductive Switching Test Circuit & Waveforms

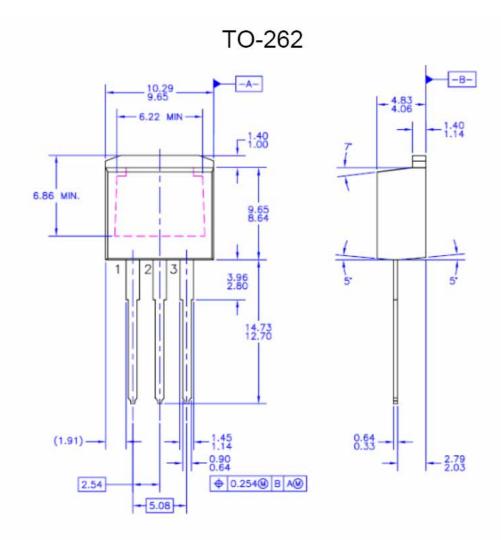


Peak Diode Recovery dv/dt Test Circuit & Waveforms





Mechanical Dimensions



Dimensions in Millimeters





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